



Edition 1.1 2021-10 CONSOLIDATED VERSION

INTERNATIONAL STANDARD

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Industrial non-destructive testing equipment - Electron linear accelerator

Appareils destinés aux essais non destructifs pour le secteur industriel – Accélérateur électronique linéaire

IEC 62976:2017





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INDUSTRIAL NON-DESTRUCTIVE TESTING EQUIPMENT – ELECTRON LINEAR ACCELERATOR

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IEC 62976 edition 1.1 contains the first edition (2017-05) [documents 45/821/FDIS and 45/824/RVD] and its amendment 1 (2021-10) [documents 45/920/CDV and 45/929/RVC].

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication.

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International Standard IEC 62976 has been prepared by technical committee 45: Nuclear instrumentation.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

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INDUSTRIAL NON-DESTRUCTIVE TESTING EQUIPMENT – ELECTRON LINEAR ACCELERATOR

1 Scope

This document gives the rules of naming, technical requirements, test methods, inspection, marking signage, packaging, transportation, storage and accompanying documents for electron linear accelerator equipment for Non-Destructive Testing (NDT).

This document applies to NDT electron linear accelerator equipment in the X-ray energy range of 1 MeV to 15 MeV, including the accelerator equipment for radiographic film, computed radiography with imaging plates, real-time imaging, digital detector array and industrial computerized tomography.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO/IEC Guide 37:2012, Instructions for use of products by consumers

ISO 780:2015, Packaging – Distribution packaging – Graphical symbols for handling and storage of packages

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ISO 19232-1:2013, Non-destructive testing – Image quality of radiographs – Part 1: Determination of the image quality value using wire-type image quality indicators

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at http://www.electropedia.org/
- ISO Online browsing platform: available at http://www.iso.org/obp

3.1

target

area on the surface of accelerating tube outlet on which the electron beam impinges and from which the primary beam of X-rays is emitted

3.2

linear electron accelerator

LINAC

apparatus for producing high energy electrons by accelerating them along a waveguide. The electrons strike a target to produce X-rays

Note 1 to entry: NDT electron linear accelerator, hereinafter referred to as the accelerator.

[SOURCE: ISO 5576:1997, 2.84]

3.3

X-rays

penetrating electromagnetic radiation, within the approximate wavelength range of 1 nm to 0,0001 nm, produced when high velocity electrons impinge on a metal target

[SOURCE: ISO 5576:1997, 2.129]

3.4

X-ray beam energy

E

maximum X-ray energy in the continuous emission spectrum, equal to the product of the electron charge and the accelerating voltage

Note 1 to entry: E is expressed in megaelectronvolts (MeV).

3.5

wedge X-ray field

X-radiation field with a dose distribution that changes approximately linearly with distance from the beam edge along a line perpendicular to and passing through the radiation beam axis

[SOURCE: IEC 60976, 2007, 3.32]

3.6

half-value layer 1 en STANDARD PREVIEW

thickness of a specified material, which attenuates under narrow beam conditions X- radiation with a particular spectrum to an extent such that the air kerma rate, exposure rate or absorbed dose rate is reduced to one half of the value that is measured without the material. The half-value layer (HVL) is expressed in suitable submultiples of the metre together with the material

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[SOURCE: IEC 60601-1-3, 2008, 3.27]

3.7

X-ray beam focal spot

d

dimension across the focal spot of an accelerating tube, measured perpendicular to the central beam axis

Note 1 to entry: d is expressed in millimetres (mm).

3.8

X-ray beam homogeneity

ratio, expressed as a percent, of the dose rate in a plane 1 m from the target and normal to the beam central axis, and acquired at a specified angle from the central axis, to the dose rate in the plane and on the beam axis

3.9

X-ray beam air kerma rate

K

volume of ionization caused by the x-ray beam in air per unit time at 1 m away from target

Note 1 to entry: $\it K$ is expressed in centigrays per minute (cGy/min).

3.10

X-ray beam asymmetry

ratio of the difference to the average values of the dose rates measured at equal distances from the central beam axis and in a vertical plane normal to the x-ray beam

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Note 1 to entry: This ratio is expressed as a percentage.

X-ray sensitivity

ratio of the minimum defect size that can be observed in the detector to the thickness of the penetrated material

Note 1 to entry: This ratio is expressed as a percentage.

3.12

X-ray head

part of an X-ray installation that contains the accelerating tube and its shield

Equipment sets, names and work conditions

4.1 **Equipment sets**

Generally, the equipment consists of the following components:

- a) X-ray head,
- b) modulator,
- c) temperature control unit (TCU),
- d) control system,
- e) power distribution cabinet, TANDARD PREVIEW
- f) safety interlock system,
- g) interconnecting cables (X-ray head to modulator, modulator to console) and hoses (TCU to X-ray head).

Name convention 4.2

The naming rules of the equipment are shown in Figure 1.

XX-XX/XXX Maximum X-ray dose-rate, cGy/min - X-ray energy, MeV IEC

Figure 1 - Naming convention

The specifications of several commonly used accelerator models are shown in Table 1.

Table 1 – Specifications of several commonly used accelerator models

	Specif	ication
Model No.	X-ray beam energy	Maximum X-ray dose rate
	MeV	cGy/min
XX-2/200	2	200
XX-4/500	4	500
XX-6/1000	6	1 000
XX-9/3000	9	3 000
XX-12/5000	12	5 000
XX-15/12000	15	12 000

4.3 Operating conditions

4.3.1 Environmental requirement

environment temperature: (5 to 40) °C;

relative humidity: ≤90 %.

4.3.2 Power supply

- voltage: 380 V ±10 % three-phase four-wire AC system;
- frequency: 50 Hz ±2 % / 60 Hz ±2 %;
- power supply: it is put forward in the product manual according to the accelerator model;
- grounding resistance: special grounding resistance of modulator is less than 4 Ω .

5 Technical requirements

5.1 Appearance

The surface shall be smooth, uniform color, no obvious scratches, bumps or holes.

5.2 Control system

5.2.1 Design principle

The design of the control system shall ensure the safety of the operator, the device and the delivered dose.

5.2.2 Operation of start and stop

Operation of X-ray source start and stop shall be executed in the control console.

5.2.3 Functions of control system

The basic functions of the control system shall include:

- normal start-up and shut-down,
- display of the status of normal, fault, alarm and auto-stop,
- display of the main operational parameters,
- safety interlock,
- emergency stop.

5.3 Performance

5.3.1 X-ray beam energy

Commonly used X-ray beam energies of accelerators are shown in Table 2 and the corresponding half value layer should not be less than the value in Table 2.

Table 2 – Half value layer of materials corresponding to commonly used X-ray beam energies

X-ray beam energy	Steel (Material density: 7,8 × 10 ³ kg/m ³)	Plexiglas (Material density:1,7 × 10 ³ kg/m ³)
MeV	mm	mm
1	16 ± 0,5	61 ± 2
2	20 ± 0,5	84 ± 2
4	25 ± 0,5	116 ± 2
6	28 ± 0,5	138 ± 2
9	30 ± 0,5	149 ± 2
12	32 ± 0,5	178 ± 2
15	33 ± 0,5	204 ± 2

5.3.2 X-ray homogeneity TANDARD PREVIEW

X-ray homogeneity shall not be less than the value in Table 3 by using a beam flattening filter.

Table 3 - X-ray homogeneity of commonly used X-ray beam energies

X-ray beam energy	Subtended angle A between beam central axis and axis connecting the centre of focal spot with the point of measurement located on the circumference	42 X-ray homogeneity	
MeV	(°)	%	
1	7,5	80	
2	7,5	78	
4	7,5	75	
6	7,5	62	
9	7,5	55	
12	6,0	50	
15	6,0	45	

5.3.3 X-ray beam air kerma rate

X-ray beam air kerma rate shall achieve the value shown in Table 4 (can be reduced based on purpose).